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SN54LVTH16241, SN74LVTH16241 3.3-V ABT 16-BIT BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

SCBS693D-MAY 1997-REVISED NOVEMBER 2006

FEATURES

- Members of the Texas Instruments Widebus™ **Family**
- State-of-the-Art Advanced BiCMOS Technology (ABT) Design for 3.3-V Operation and Low Static-Power Dissipation
- Support Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V V_{CC})
- **Support Unregulated Battery Operation Down** to 2.7 V
- Typical V_{OLP} (Output Ground Bounce) <0.8 V at $V_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- I_{off} and Power-Up 3-State Support Hot Insertion
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Distributed V_{CC} and GND Pin Configuration **Minimizes High-Speed Switching Noise**
- Flow-Through Architecture Optimizes PCB Layout
- Latch-Up Performance Exceeds 500 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- **Package Options Include Plastic Shrink** Small-Outline (DL) and Thin Shrink Small-Outline (DGG) Packages and 380-mil Fine-Pitch Ceramic Flat (WD) Package Using 25-mil Center-to-Center Spacings

SN54LVTH16241 . . . WD PACKAGE SN74LVTH16241 . . . DGG OR DL PACKAGE (TOP VIEW)

1 <u>0E</u>	1	48] 20E
1Y1	2	47] 1A1
1Y2 [3	46] 1A2
GND [4	45	GND
1Y3 [5	44] 1A3
1Y4 [6	43] 1A4
V _{cc} [7	42	V_{cc}
2Y1[8	41] 2A1
2Y2 [9	40	2A2
GND [10	39	GND
2Y3 [11	38] 2A3
2Y4 [12	37] 2A4
3Y1[13	36] 3A1
3Y2 [14	35] 3A2
GND [15	34	GND
3Y3 [16	33] 3A3
3Y4 [17	32] 3A4
V _{cc} [18	31	V_{cc}
4Y1[19	30] 4A1
4Y2 [20	29] 4A2
GND [21	28	GND
4Y3 [22	27] 4A3
4Y4 [23	26] 4A4
4 0E [24	25	30E

DESCRIPTION/ORDERING INFORMATION

These 16-bit buffers/drivers are designed specifically for low-voltage (3.3-V) V_{CC} operation, but with the capability to provide a TTL interface to a 5-V system environment.

The devices can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. The devices provide noninverting outputs and complementary output-enable (OE and \overline{OE}) inputs.

ORDERING INFORMATION

T _A	PACK	AGE ⁽¹⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING		
		Reel of 1000	74LVTH16241DLRG4			
	CCOD DI	Reel of 1000	SN74LVTH16241DLR	1 V/TLI4 CO 44		
400C to 050C	SSOP – DL	T. 1. 105	SN74LVTH16241DL	LVTH16241		
-40°C to 85°C		Tube of 25	SN74LVTH16241DLG4			
	TOCOD DOC	Deal of 2000	74LVTH16241DGGRE4	L V/TL 14 CO 44		
	TSSOP – DGG	Reel of 2000	SN74LVTH16241DGGR	LVTH16241		

⁽¹⁾ Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

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DESCRIPTION/ORDERING INFORMATION (CONTINUED)

When V_{CC} is between 0 and 1.5 V, the devices are in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, \overline{OE} should be tied to V_{CC} through a pullup resistor and OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

These devices are fully specified for hot-insertion applications using I_{off} and power-up 3-state. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

The SN54LVTH16241 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74LVTH16241 is characterized for operation from –40°C to 85°C.

FUNCTION TABLES

INPL	INPUTS					
10E, 40E	1A, 4A	1Y, 4Y				
L	Н	Н				
L	L	L				
Н	Χ	Z				

INPU	INPUTS					
20E, 30E	2A, 3A	2Y, 3Y				
Н	Н	Н				
Н	L	L				
L	Χ	Z				



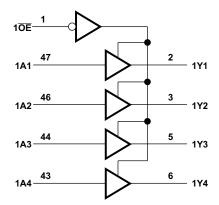


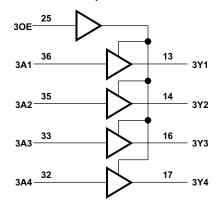
LOGIC SYMBOL(A) 10E EN1 48 20E EN2 25 30E EN3 24 40E EN4 47 2 1 1 ▽ 1Y1 1A1 3 1A2 1Y2 5 44 1A3 1Y3 43 6 1Y4 1A4 41 8 2 ▽ 1 2A1 2Y1 40 2A2 2Y2 38 11 2A3 2Y3 37 12 2A4 2Y4 36 13 1 3 ▽ 3Y1 3A1 35 14 3A2 3Y2 33 16 3A3 3Y3 32 17 3Y4 3A4 30 19 4 ▽ 4A1 1 4Y1 29 20 4A2 4Y2 27 22 4Y3 4Y4 4A4

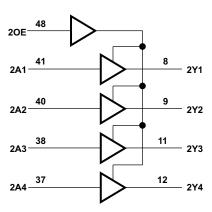
A. This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

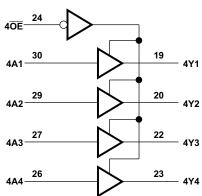


LOGIC DIAGRAM (POSITIVE LOGIC)









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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	4.6	V
VI	Input voltage range ⁽²⁾	nput voltage range ⁽²⁾			
Vo	Voltage range applied to any output in the high	-0.5	7	V	
Vo	Voltage range applied to any output in the high	-0.5	V _{CC} + 0.5	V	
	Current into any output in the low state	SN54LVTH16241		96	mA
10	Current into any output in the low state	SN74LVTH16241		128	IIIA
	Current into any output in the high state (3)	SN54LVTH16241		48	A
IO	Current into any output in the high state (3)	SN74LVTH16241		64	mA
I _{IK}	Input clamp current	V _I < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
0	Deales as the second increased as as (4)	DGG package		89	°C/W
θ_{JA}	Package thermal impedance ⁽⁴⁾	DL package		94	- C/VV
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

Recommended Operating Conditions⁽¹⁾

			SN54LVTH	16241 ⁽²⁾	SN74LVTH	SN74LVTH16241	
			MIN	MAX	MIN MAX		UNIT
V _{CC}	Supply voltage		2.7	3.6	2.7	3.6	V
V _{IH}	High-level input voltage		2		2		V
V _{IL}	Low-level input voltage		0.8		0.8	V	
VI	Input voltage		5.5		5.5	V	
I _{OH}	High-level output current			-24		-32	mA
I _{OL}	Low-level output current			48		64	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled		10		10	ns/V
$\Delta t/\Delta V_{CC}$	Power-up ramp rate	•	200		200		μs/V
T _A	Operating free-air temperature		-55	125	-40	85	°C

⁽¹⁾ All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

Product Preview

 ⁽²⁾ The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
(3) This current flows only when the output is in the high state and V_O > V_{CC}.
(4) The package thermal impedance is calculated in accordance with JESD 51.

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Electrical Characteristics

over recemmended operating free-air temperature range (unless otherwise noted)

D.4	DAMETED	TEST CO	MOITIONS	SN54L	VTH16241	(1)	SN74L	VTH16241		LINUT
PA	RAMETER	IESI CC	ONDITIONS	MIN	TYP ⁽²⁾	MAX	MIN	TYP ⁽²⁾	MAX	UNIT
V_{IK}		$V_{CC} = 2.7 \text{ V},$	$I_I = -18 \text{ mA}$			-1.2			-1.2	V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V},$	$I_{OH} = -100 \mu A$	V _{CC} - 0.2			V _{CC} - 0.2			
V		$V_{CC} = 2.7 \text{ V},$	$I_{OH} = -8 \text{ mA}$	2.4			2.4			V
V _{OH}		V 2.V	$I_{OH} = -24 \text{ mA}$	2						V
		$V_{CC} = 3 V$	$I_{OH} = -32 \text{ mA}$				2			
		V 0.7.V	I _{OL} = 100 μA			0.2			0.2	
		$V_{CC} = 2.7 \text{ V}$	I _{OL} = 24 mA			0.5			0.5	
V			I _{OL} = 16 mA			0.4			0.4	V
V _{OL}		V 2.V	I _{OL} = 32 mA			0.5			0.5	V
		$V_{CC} = 3 V$	I _{OL} = 48 mA			0.55				
			I _{OL} = 64 mA						0.55	
		$V_{CC} = 0 \text{ or } 3.6 \text{ V},$	V _I = 5.5 V			10			10	
I _I	Control inputs	V _{CC} = 3.6 V,	V _I = V _{CC} or GND			±1			±1	μΑ
	Data issues		$V_I = V_{CC}$			1			1	•
	Data inputs	V _{CC} = 3.6 V	V _I = 0			- 5			-5	
I _{off}		$V_{CC} = 0$,	V_I or $V_O = 0$ to 4.5 V			±100		:	±100	μΑ
		V 2.V	V _I = 0.8 V	75			75			
I _{I(hold)}	Data inputs	$V_{CC} = 3 V$	V _I = 2 V	-75			-75			μΑ
'I(noia)	Data inputs	$V_{CC} = 3.6 V^{(3)},$	V _I = 0 to 3.6 V						500 -750	μπ
I _{OZH}		$V_{CC} = 3.6 \text{ V},$	V _O = 3 V			5			5	μΑ
I _{OZL}		$V_{CC} = 3.6 \text{ V},$	V _O = 0.5 V			- 5			-5	μΑ
I _{OZPU}		$V_{CC} = 0$ to 1.5 V, $V_{O} = 0$ OE/OE = don't care	0.5 V to 3 V,		=	±100 ⁽⁴⁾		:	±100	μΑ
I _{OZPD}		$V_{CC} = 1.5 \text{ V to } 0, V_{O} = 0$ OE/OE = don't care	0.5 V to 3 V,		=	±100 ⁽⁴⁾		:	±100	μΑ
		V _{CC} = 3.6 V,	Outputs high			0.19			0.19	
I _{CC}		$I_{O} = 0$,	Outputs low			5			5	mA
		$V_I = V_{CC}$ or GND	Outputs disabled			0.19			0.19	
ΔI _{CC} ⁽⁵⁾	ı	V _{CC} = 3 V to 3.6 V, Or Other inputs at V _{CC} or	ne input at V _{CC} – 0.6 V, GND			0.2			0.2	mA
Ci		V _I = 3 V or 0			4			4		pF
Co		V _O = 3 V or 0			9			9		pF

 ⁽¹⁾ Product Preview
(2) All typical values are at V_{CC} = 3.3 V, T_A = 25°C.
(3) This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to

 ⁽⁴⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested.
(5) This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.

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Switching Characteristics

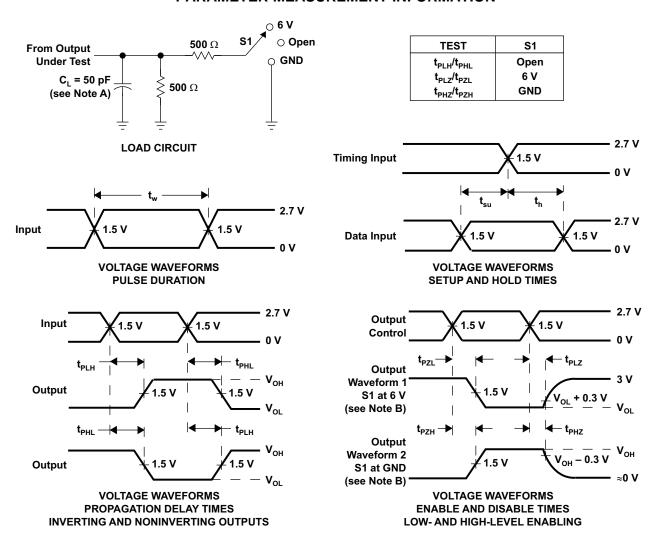
over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	SN54LVTH16241 ⁽¹⁾				SN74LVTH16241					UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	TYP ⁽²⁾	MAX	MIN	MAX	ONIT
t _{PLH}	۸		1.1	3.7		4	1.2	2.6	3.5		3.8	20
t _{PHL}	A	T	1.1	3.7		4	1.2	2.2	3.5		3.8	ns
t _{PZH}	OE or OE	Υ	1.1	4.7		5.3	1.2	3.2	4.5		5.1	ns
t _{PZL}	OE 01 OE	T	1.1	4.7		5.2	1.2	3.2	4.5		4.9	113
t _{PHZ}	OE or OE		1.9	5.5		6.1	2	3.7	5.3		5.9	20
t _{PLZ}	OE OF OE	Ť	1.9	5.2		5.7	2	3.4	4.9		5.4	ns
t _{sk(LH)}									0.5		0.5	20
t _{sk(HL)}									0.5		0.5	ns

⁽¹⁾ Product Preview (2) All typical values are at V_{CC} = 3.3 V, T_A = 25°C.



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_i includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_0 = 50 Ω , $t_r \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





28-Aug-2010

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
74LVTH16241DGGRE4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distributor or Sales Office
74LVTH16241DGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distributor or Sales Office
SN74LVTH16241DGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distributor or Sales Office
SN74LVTH16241DL	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distributor or Sales Office
SN74LVTH16241DLG4	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distributor or Sales Office

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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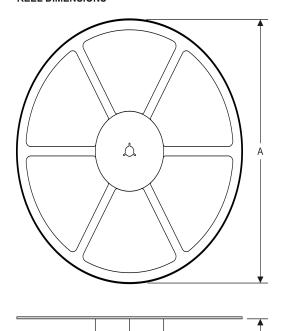
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PACKAGE MATERIALS INFORMATION

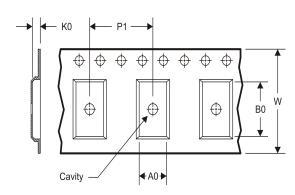
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TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	_	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVTH16241DGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	15.8	1.8	12.0	24.0	Q1

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVTH16241DGGR	TSSOP	DGG	48	2000	367.0	367.0	45.0

DL (R-PDSO-G**)

48 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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